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| APPLICATION NO. | FILING DATE | FIRST NAMED INVENTOR | ATTORNEY DOCKET NO. | CONFIRMATION NO. | |
|--|-----------------|------------------------|-------------------------|------------------|--|
| 10/604,517 | 07/28/2003 | Timothy H. Daubenspeck | BUR920020115US1 | 1516 | |
| 23389 | 7590 07/14/2004 | | EXAM | EXAMINER | |
| SCULLY SCOTT MURPHY & PRESSER, PC 400 GARDEN CITY PLAZA | | | DUONG, KHANH B | | |
| | TY, NY 11530 | | ART UNIT | PAPER NUMBER | |
| | , | | 2822 | | |
| | | | DATE MAILED: 07/14/2004 | Į. | |

Please find below and/or attached an Office communication concerning this application or proceeding.

| | Application No. | Applicant(s) | |
|---|---|---|------------------------|
| | 10/604,517 | DAUBENSPECK ET AL. | |
| Office Action Summary | Examiner | Art Unit | |
| | Khanh Duong | 2822 | 17 |
| The MAILING DATE of this communicate Period for Reply | ion appears on the cover sheet w | ith the correspondence a | ddress |
| A SHORTENED STATUTORY PERIOD FOR THE MAILING DATE OF THIS COMMUNICA - Extensions of time may be available under the provisions of 37 after SIX (6) MONTHS from the mailing date of this communic - If the period for reply specified above is less than thirty (30) da - If NO period for reply is specified above, the maximum statutor - Failure to reply within the set or extended period for reply will, Any reply received by the Office later than three months after the earned patent term adjustment. See 37 CFR 1.704(b). | TION. 'CFR 1.136(a). In no event, however, may a ration. ys, a reply within the statutory minimum of thirtry period will apply and will expire SIX (6) MON by statute, cause the application to become AB | eply be timely filed y (30) days will be considered time THS from the mailing date of this o | ely. communication. |
| Status | | | |
| 1) Responsive to communication(s) filed o | n <u>26 A<i>pril</i> 2004</u> . | | |
| · · · · · · · · · · · · · · · · · · · | ☐ This action is non-final. | | |
| 3) Since this application is in condition for | allowance except for formal matt | ers, prosecution as to th | e merits is |
| closed in accordance with the practice (| ınder <i>Ex parte Quayl</i> e, 1935 C.D | . 11, 453 O.G. 213. | |
| Disposition of Claims | | | |
| 4) ☐ Claim(s) 1-15 is/are pending in the applied 4a) Of the above claim(s) 8-15 is/are wite 5) ☐ Claim(s) is/are allowed. 6) ☐ Claim(s) 1-7 is/are rejected. 7) ☐ Claim(s) is/are objected to. 8) ☐ Claim(s) are subject to restriction. | hdrawn from consideration. | | |
| Application Papers | | | |
| 9) The specification is objected to by the Ex 10) The drawing(s) filed on 28 July 2003 is/a Applicant may not request that any objection Replacement drawing sheet(s) including the 11) The oath or declaration is objected to by | re: a) accepted or b) object to the drawing(s) be held in abeyan correction is required if the drawing(| ce. See 37 CFR 1.85(a). s) is objected to. See 37 C | , , |
| Priority under 35 U.S.C. § 119 | | | |
| 12) Acknowledgment is made of a claim for f a) All b) Some * c) None of: 1. Certified copies of the priority doc 2. Certified copies of the priority doc 3. Copies of the certified copies of the application from the International I * See the attached detailed Office action for | uments have been received. uments have been received in Ap e priority documents have been Bureau (PCT Rule 17.2(a)). | oplication No received in this National | Stage |
| Attachment(s) | | | |
| 1) Notice of References Cited (PTO-892) | 4) 🔲 Interview Su | ummary (PTO-413) | |
| Notice of Draftsperson's Patent Drawing Review (PTO-93) Information Disclosure Statement(s) (PTO-1449 or PTO/Paper No(s)/Mail Date 7/28/03. | | /Mail Date formal Patent Application (PTC _ | D-152) |

DETAILED ACTION

Response to Applicant's Election

Applicant's election with traverse of Group II, claims 1-7 in the reply filed on April 26, 2004 is acknowledged. The traversal is on the ground(s) that the Examiner's reason is insufficient to support the restriction requirement and that such restriction requirement contravenes "the constitutional purpose to promote and encourage the progress of science and the useful arts". This is not found persuasive because Applicant has not specifically addressed why the reason for restriction is insufficient in the view of one of ordinary skill in the art.

The requirement is still deemed proper and is therefore made FINAL.

Specification

The disclosure is objected to because of the following informalities: paragraph [0005], line 1 to 2, the phrase "cracks form that can ... causing fails" should be --cracks formed can ... causing failures--.

Appropriate correction is required.

*** Applicant is further advised to recheck the entire specification for other grammatical errors.

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless –

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Art Unit: 2822

Claims 1, 4, 5 and 7 are rejected under 35 U.S.C. 102(b) as being anticipated by Suwanai et al. (U.S. 5,994,762), submitted in IDS.

Suwanai et al. ("Suwanai") discloses in FIG. 2 a crack stop for an integrated circuit (IC) chip 1 having an active circuit area, comprising: the IC chip 1 including metal interconnects which do not form a self-passivating oxide layer, in a low-K dielectric material (BPSG: 17, 20, 23); a moisture barrier/edge seal (GR: 18, 21, 24) positioned along the outer peripheral edges of the active area of the IC chip 1; a crack stop formed by at least one trench or void region S outside of the moisture barrier/edge seal GR on the outer periphery of the IC chip 1, for preventing damage to the active area of the IC chip 1 caused by chipping and cracking formed along peripheral edges of the IC chip 1 during a dicing operation performed on the IC chip 1 (see col. 6 to 9).

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

The factual inquiries set forth in *Graham* v. *John Deere Co.*, 383 U.S. 1, 148 USPQ 459 (1966), that are applied for establishing a background for determining obviousness under 35 U.S.C. 103(a) are summarized as follows:

- 1. Determining the scope and contents of the prior art.
- 2. Ascertaining the differences between the prior art and the claims at issue.
- 3. Resolving the level of ordinary skill in the pertinent art.
- 4. Considering objective evidence present in the application indicating obviousness or nonobviousness.

Claims 2 and 3 are rejected under 35 U.S.C. 103(a) as being unpatentable over Suwanai in view of Ma et al. (U.S. 6,509,622).

Re claims 2 and 3, Suwanai discloses the metal interconnects being comprised of other conductive metals, such as Ti, W and Al instead of Cu and Ag.

Ma et al. ("Ma") suggests using interconnects comprising of Cu, Ag and Al (see col. 2, ln. 41-44).

Since Suwanai and Ma are both from the same field of endeavor, the purpose disclosed by Ma would have been recognized in the pertinent prior art of Suwanai.

Therefore, because these metals were art-recognized equivalent materials for interconnects as demonstrated by Suwanai and Ma at the time the invention was made, one of ordinary skill in the art would have found it obvious to substitute one metal for the other.

Claim 6 is rejected under 35 U.S.C. 103(a) as being unpatentable over Suwanai in view of Mulligan et al. (US 2003/0100143 A1).

Re claim 6, Suwanai fails to disclose a plurality of trenches or void regions formed outside of the moiSture barrier/edge seal on the outer periphery of the IC chip.

Mulligan et al. ("Mulligan") teaches in FIG. 2 a forming two trenches 118 and 118' on both sides of each dicing street 104.

Since Suwanai and Mulligan are both from the same field of endeavor, the purpose disclosed by Mulligan would have been recognized in the pertinent prior art of Suwanai.

Therefore, it would have been obvious to one of ordinary skill in the art to modify the device of Suwanai with a plurality of trenches as taught by Mulligan, since such modification would prevent cracking and/or delamination problems on both sides of each dicing street.

Art-Unit: 2822

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Khanh Duong whose telephone number is (571) 272-1836. The examiner can normally be reached on Monday - Thursday (9:00 AM - 6:00 PM).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Amir Zarabian can be reached on (571) 272-1852. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

KBD

Michael Trinh Primary Examiner

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